

Notice of References Cited

Application/Control No.

10/079,817

Applicant(s)/Patent Under
Reexamination
NAKABAYASHI ET AL.

Examiner

Tuan M Nguyen

Art Unit

2828

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,603,782 B2 ✓ | 08-2003 | Nakanishi et al. | 372/36 |
| | B | US-6,459,710 B1 ✓ | 10-2002 | Whitney et al. | 372/29.02 |
| | C | US-6,374,021 B1 ✓ | 04-2002 | Nakanishi et al. | 385/49 |
| | D | US-5,787,215 ✓ | 07-1998 | Kuhara et al. | 385/88 |
| | E | US-5,845,031 A ✓ | 12-1998 | Aoki, Hiroatsu | 385/92 |
| | F | US-5,526,160 A ✓ | 06-1996 | Watanabe et al. | 398/138 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.